

Notice of References Cited	Application/Control No.	Applicant(s)/Patent Under Reexamination	
	10/720,820	NAGEL ET AL.	
	Examiner	Art Unit	Page 1 of 1
John J. Figueroa	1712		

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-2004/0256515 A1	12-2004	Eikmeier et al.	242/556.1
*	B	US-RE34,279	06-1993	Blake, Frederick D.	524/145
*	C	US-3,575,911	04-1971	Richard I. Peterson	524/340
	D	US-			
	E	US-			
	F	US-			
	G	US-			
	H	US-			
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N	WO 2003020623 A1	03-2003	World Intellect	EIKMEIER et al.	-----
	O					
	P					
	Q					
	R					
	S					
	T					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	W	
	X	

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.